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May 2014

FCA36N60NF

N-Channel SupreMOS[®] FRFET[®] MOSFET 600 V, 34.9 A, 95 m Ω

Features

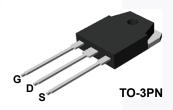
- $R_{DS(on)}$ = 80 m Ω (Typ.) @ V_{GS} = 10V, I_D = 18 A
- Ultra Low Gate Charge (Typ. Q_g = 86 nC)
- Low Effective Output Capacitance (Typ. $C_{oss(eff.)} = 338 pF$)
- · 100% Avalanche Tested
- · RoHS Compliant

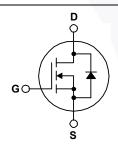
Application

- · Solar Inverter
- · AC-DC Power Supply

Description

The SupreMOS® MOSFET is Fairchild Semiconductor's next generation of high voltage super-junction (SJ) technology employing a deep trench filling process that differentiates it from the conventional SJ MOSFETs. This advanced technology and precise process control provides lowest Rsp on-resistance, superior switching performance and ruggedness. SupreMOS MOSFET is suitable for high frequency switching power converter applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. SupreMOS FRFET® MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter	FCA36N60NF		Unit	
V _{DSS}	Drain to Source Voltage			600	V	
V _{GSS}	Gate to Source Voltage			±30	V	
I _D	Continuous ($T_C = 25^{\circ}C$)			34.9	^	
	Drain Current	Continuous (T _C = 100°C)	Continuous (T _C = 100°C)		A	
I _{DM}	Drain Current	Pulsed	(Note 1)	104.7	Α	
E _{AS}	Single Pulsed Avalanch	e Energy	(Note 2)	1800	mJ	
I _{AR}	Avalanche Current	alanche Current (N		12	Α	
E _{AR}	Repetitive Avalanche Er	gy (Note 1)		3.12	mJ	
dv/dt	MOSFET dv/dt			100	V/ns	
uv/at	Peak Diode Recovery de	v/dt	(Note 3)	50	V/IIS	
n	Dawar Dissination	(T _C = 25°C)		312	W	
P_{D}	Power Dissipation	Derate Above 25°C		2.6	W/°C	
T _J , T _{STG}	Operating and Storage	Temperature Range		-55 to +150	°С	
T _L	Maximum Lead Tempera 1/8" from Case for 5 Sec	3 ·		300	°C	

Thermal Characteristics

Symbol	Parameter	FCA36N60NF	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.40	
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink, Typ.	0.24	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCA36N60NF	FCA36N60NF	TO-3PN	Tube	N/A	N/A	30 units

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit			
Off Characteristics									
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}, T_J = 25^{\circ}\text{C}$	600	-	-	V			
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 1 mA, Referenced to 25°C	-	0.60	-	V/°C			
1	Zero Gate Voltage Drain Current	V _{DS} = 480 V, V _{GS} = 0 V	-	-	10				
DSS	Zero Gate Voltage Drain Current	$T_{J} = 125^{\circ}C$	-	-	100	μA			
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA			

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	3.7	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 18 A	-	80	95	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 20 V, I _D = 18 A	-	39	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 400 V V 0 V	-	3191	4245	pF
Coss	Output Capacitance	V _{DS} = 100 V, V _{GS} = 0 V, f = 1 MHz	-	145	195	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	-\	5	8	pF
Coss	Output Capacitance	V _{DS} = 380 V, V _{GS} = 0 V, f = 1 MHz	- \	81	-	pF
C _{oss} eff.	Effective Output Capacitance	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$	- \	338	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	V _{DS} = 380 V, I _D = 18 A,	-	86	112	nC
Q_{gs}	Gate to Source Gate Charge	V _{GS} = 10 V	-	16	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4)	-	36	-	nC
ESR	Equivalent Series Resistance (G-S)	f = 1 MHz	-	1.2	-	Ω

Switching Characteristics

	_						
t _{d(on)}	Turn-On Delay Time			- /	27	64	ns
t _r	Turn-On Rise Time	$V_{DD} = 380 \text{ V}, I_D = 18 \text{ A},$		-/	17	44	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_G = 4.7 Ω		-	92	194	ns
t _f	Turn-Off Fall Time		(Note 4)	-	4	18	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode	Maximum Continuous Drain to Source Diode Forward Current		-	36	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	108	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 18 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 18 A,	-	166	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	1.3	-	μС

Notes

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. I_{AS} = 12 A, R_G = 25 Ω , starting T_J = 25°C.
- 3. I $_{SD} \leq$ 36 A, di/dt \leq 1200 A/µs, V $_{DD}$ = 380 V, starting T $_{J}$ = 25°C.
- 4. Essentially independent of operating temperature typical characteristics.

Typical Performance Characteristics

Figure 1. On-Region Characteristics

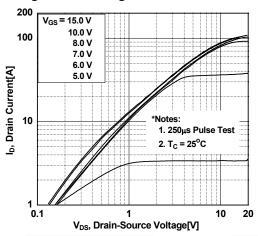


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

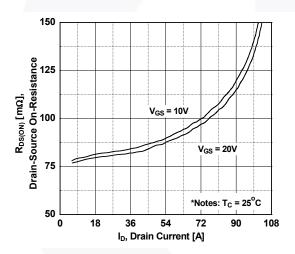


Figure 5. Capacitance Characteristics

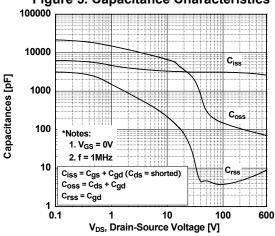


Figure 2. Transfer Characteristics

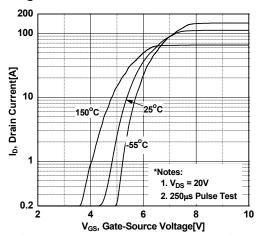


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

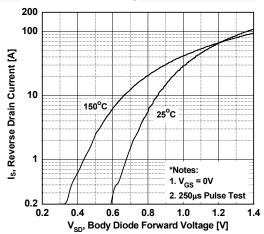
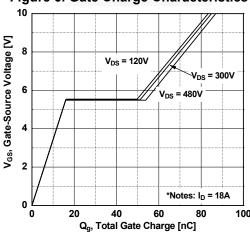


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

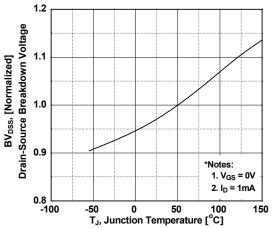


Figure 8. On-Resistance Variation vs. Temperature

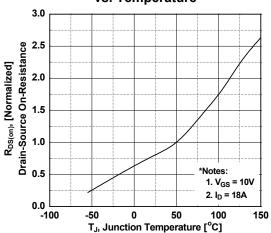


Figure 9. Maximum Safe Operating Area

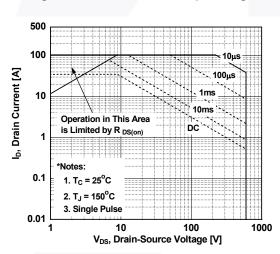


Figure 10. Maximum Drain Current vs. Case Temperature

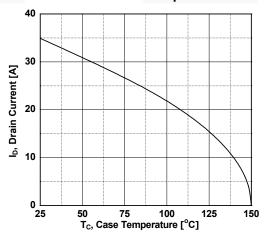
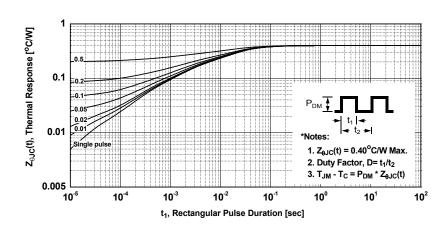


Figure 11. Transient Thermal Response Curve



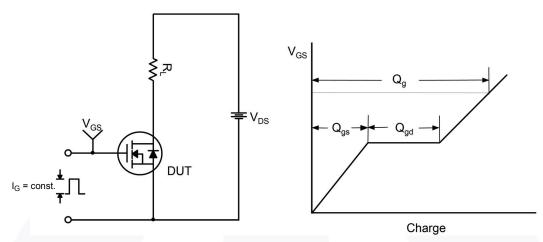


Figure 12. Gate Charge Test Circuit & Waveform

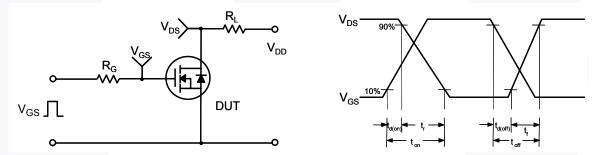


Figure 13. Resistive Switching Test Circuit & Waveforms

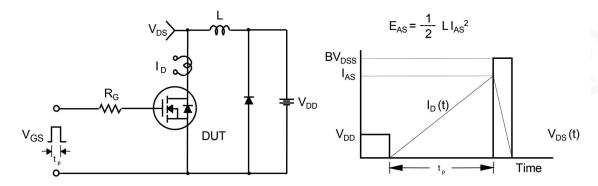


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

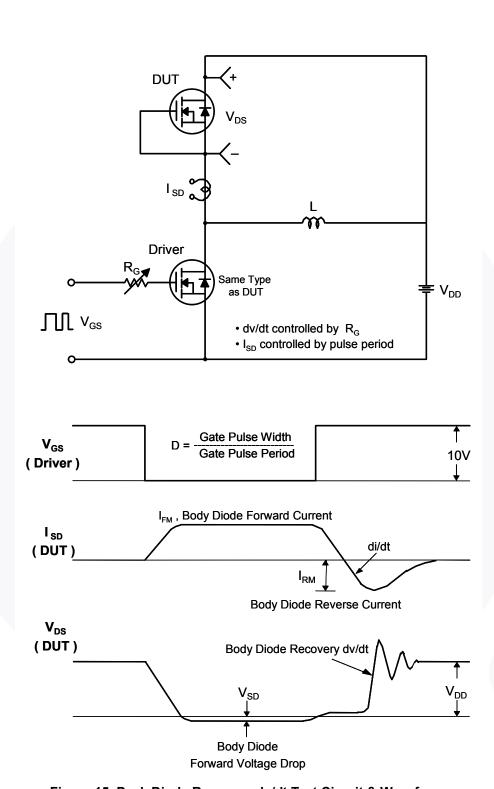
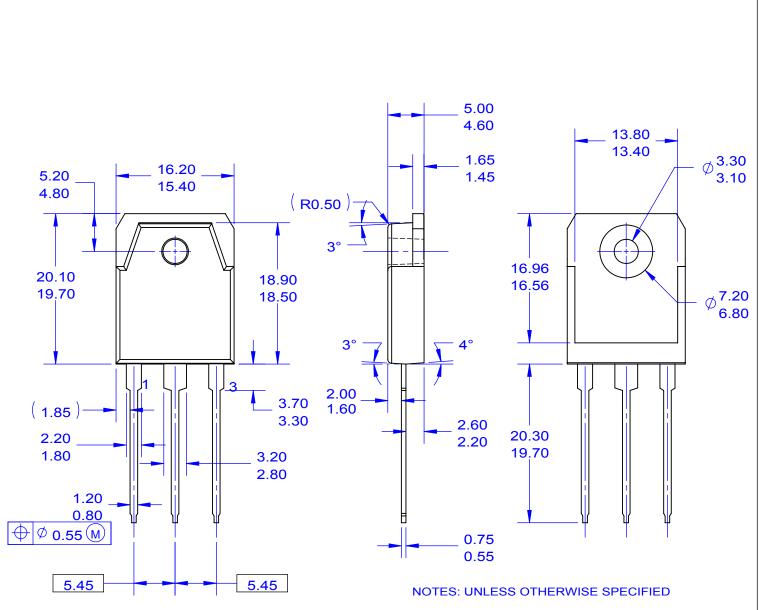
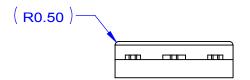


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





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